

## **Die Datasheet**

# GA20JT06-CAL

# Normally – OFF Silicon Carbide Junction Transistor

 $V_{DS}$  = 600 V  $R_{DS(ON)}$  = 65 m $\Omega$   $I_{D}$  @ 25 °C = 45 A  $h_{FE}$  = 110

#### **Features**

- 210°C maximum operating temperature
- · Gate Oxide Free SiC switch
- Exceptional Safe Operating Area
- Excellent Gain Linearity
- Temperature Independent Switching Performance
- Low Output Capacitance
- Positive Temperature Co-efficient of R<sub>DS,ON</sub>
- Suitable for connecting an anti-parallel diode

#### **Advantages**

- Compatible with Si MOSFET/IGBT gate-drivers
- > 20 µs Short-Withstand Capability
- Lowest-in-class Conduction Losses
- High Circuit Efficiency
- Minimal Input Signal Distortion
- · High Amplifier Bandwidth





Die Size = 2.85 mm x 2.85 mm

#### **Applications**

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

## Absolute Maximum Ratings (T<sub>C</sub> = 25 °C unless otherwise specified)

Parameter	Symbol	Conditions	Values	Unit	
Drain – Source Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V	600	V	
Continuous Drain Current	I <sub>D</sub>	T <sub>C</sub> = 25 °C	45	Α	
Continuous Drain Current	I <sub>D</sub>	$T_C > 125$ °C, assumes $R_{thJC} < 0.53$ °C/W	20	Α	
Gate Peak Current	$I_{GM}$		1.3	Α	
Turn-Off Safe Operating Area	RBSOA	T <sub>VJ</sub> = 210 °C, Clamped Inductive Load	$I_{D,max} = 20$ $ V_{DS} \le V_{DSmax}$	Α	
Short Circuit Safe Operating Area	SCSOA	$T_{VJ}$ = 210 °C, $I_G$ = 1 A, $V_{DS}$ = 400 V, Non Repetitive	20	μs	
Reverse Gate – Source Voltage	$V_{GS}$		30	V	
Reverse Drain – Source Voltage	V <sub>DS</sub>		40	V	
Operating Junction and Storage Temperature	$T_j$ , $T_{stg}$		-55 to 210	°C	
Maximum Processing Temperature	$T_{Proc}$	10 min. maximum	325	°C	

#### **Electrical Characteristics**

Dorometer	Comple ed	Conditions	Values		I I m ! t	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
On Characteristics						
Drain – Source On Resistance	$R_{DS(ON)}$	$\begin{array}{c} I_D = 20 \text{ A, } I_G = 400 \text{ mA, } T_j = 25 \text{ °C} \\ I_D = 20 \text{ A, } I_G = 500 \text{ mA, } T_j = 125 \text{ °C} \\ I_D = 20 \text{ A, } I_G = 1000 \text{ mA, } T_j = 175 \text{ °C} \\ I_D = 20 \text{ A, } I_G = 1000 \text{ mA, } T_j = 210 \text{ °C} \\ \end{array}$		65 90 110 140		mΩ
Gate – Source Saturation Voltage	$V_{GS,SAT}$	$_{D}$ = 20 A, $I_{D}/I_{G}$ = 40, $T_{j}$ = 25 °C $I_{D}$ = 20 A, $I_{D}/I_{G}$ = 30, $T_{j}$ = 175 °C		3.44 3.24		V
DC Current Gain	h <sub>FE</sub>	$\begin{array}{c} V_{DS} = 5 \text{ V, } I_{D} = 20 \text{ A, } T_{J} = 25 \text{ °C} \\ V_{DS} = 5 \text{ V, } I_{D} = 20 \text{ A, } T_{J} = 125 \text{ °C} \\ V_{DS} = 5 \text{ V, } I_{D} = 20 \text{ A, } T_{J} = 175 \text{ °C} \\ V_{DS} = 5 \text{ V, } I_{D} = 20 \text{ A, } T_{J} = 210 \text{ °C} \\ \end{array}$		110 78 73 71		
Off Characteristics						
Drain Leakage Current	I <sub>DSS</sub>	$V_R = 600 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25 \text{ °C}$ $V_R = 600 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 210 \text{ °C}$		10 100		μΑ
Gate – Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = -20 \text{ V}, T_j = 25 \text{ °C}$		20		nA

# **Die Datasheet**

#### **Electrical Characteristics**

Parameter	Symbol	Conditions	Values			Unit	
Fai allietei	Symbol	Conditions	min.	typ.	max.	Oilit	
Capacitance Characteristics							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V}, V_{D} = 100 \text{ V}, f = 1 \text{ MHz}$		2100		pF	
Reverse Transfer/Output Capacitance	$C_{rss}/C_{oss}$	$V_D = 100 \text{ V}, f = 1 \text{ MHz}$		160		pF	

## **Figures**

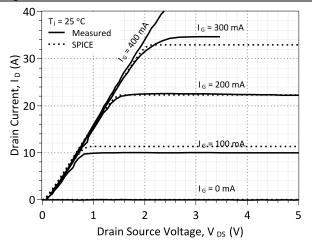


Figure 1: Typical Output Characteristics at 25 °C

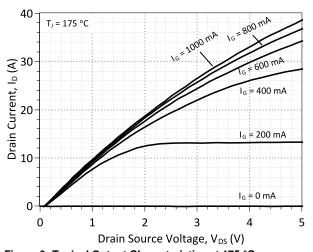


Figure 3: Typical Output Characteristics at 175  $^{\circ}\text{C}$ 

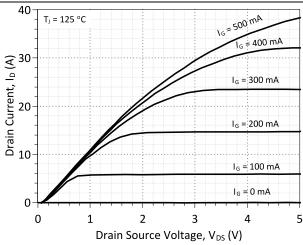


Figure 2: Typical Output Characteristics at 125 °C

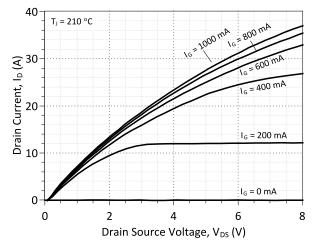


Figure 4: Typical Output Characteristics at 210 °C

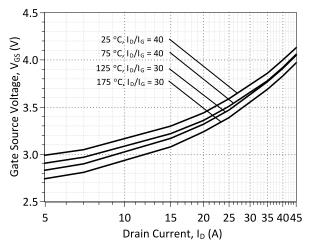
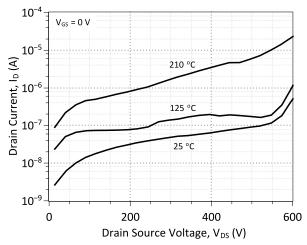


Figure 5: Typical Gate - Source Saturation Voltage



**Figure 7: Typical Blocking Characteristics** 

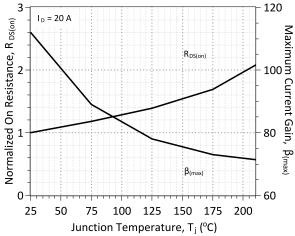


Figure 6: Normalized On-Resistance and Current Gain vs. Temperature

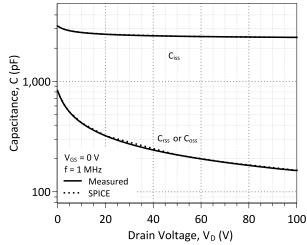


Figure 8: Capacitance Characteristics



## **Driving the GA20JT06-CAL**

Drive Topology	Gate Drive Power Consumption	Switching Frequency	Application Emphasis	Availability
TTL Logic	High	Low	Wide Temperature Range	Coming Soon
Constant Current	Medium	Medium	Wide Temperature Range	Coming Soon
High Speed – Boost Capacitor	Medium	High	Fast Switching	Production
High Speed – Boost Inductor	Low	High	Ultra Fast Switching	Coming Soon
Proportional	Lowest	High	Wide Drain Current Range	Coming Soon
Pulsed Power	Medium	N/A	Pulse Power	Coming Soon

### A: Static TTL Logic Driving

The GA20JT06-CAL may be driven using direct (5 V) TTL logic after current amplification. The (amplified) current level of the supply must meet or exceed the steady state gate current ( $I_{G,steady}$ ) required to operate the GA20JT06- CAL. The power level of the supply can be estimated from the target duty cycle of the particular application.  $I_{G,steady}$  is dependent on the anticipated drain current ID through the SJT and the DC current gain  $I_{FE}$ , it may be calculated from the following equation. An accurate value of the  $I_{FE}$  may be read from Figure 6.

$$I_{G,steady} \approx \frac{I_D}{h_{FE}(T, I_D)} * 1.5$$

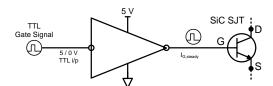


Figure 9: TTL Gate Drive Schematic

### **B: High Speed Driving**

The SJT is a current controlled transistor which requires a positive gate current for turn-on as well as to remain in on-state. An ideal gate current waveform for ultra-fast switching of the SJT, while maintaining low gate drive losses, is shown in Figure 10 which features a positive current peak during turn-on, a negative current peak during turn-off, and continuous gate current to remain on.

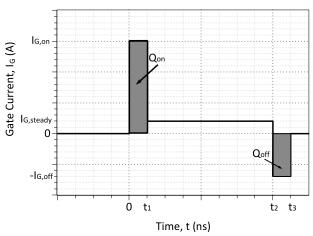


Figure 10: An idealized gate current waveform for fast switching of an SJT.

An SJT is rapidly switched from its blocking state to on-state, when the necessary gate charge,  $Q_G$ , for turn-on is supplied by a burst of high gate current,  $I_{G,on}$ , until the gate-source capacitance,  $C_{GS}$ , and gate-drain capacitance,  $C_{GD}$ , are fully charged.

$$Q_{on} = I_{G,on} * t_1$$

$$Q_{on} \ge Q_{as} + Q_{ad}$$



Ideally,  $I_{G,pon}$  should terminate when the drain voltage falls to its on-state value in order to avoid unnecessary drive losses during the steady on-state. In practice, the rise time of the  $I_{G,on}$  pulse is affected by the parasitic inductances,  $L_{par}$  in the device package and drive circuit. A voltage developed across the parasitic inductance in the source path,  $L_s$ , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The voltage applied to the gate pin should be maintained high enough, above the  $V_{GS,sat}$  (see Figure 5) level to counter these effects.

A high negative peak current,  $-I_{G,off}$  is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. While satisfactory turn off can be achieved with  $V_{GS} = 0$  V, a negative gate voltage  $V_{GS}$  may be used in order to speed up the turn-off transition.

Two high-speed drive topologies for the SiC SJTs are presented below.

#### B:1: High Speed, Low Loss Drive with Boost Capacitor, GA03IDDJT30-FR4

The GA20JT06- CAL may be driven using a High Speed, Low Loss Drive with Boost Capacitor topology in which multiple voltage levels, a gate resistor, and a gate capacitor are used to provide fast switching current peaks at turn-on and turn-off and a continuous gate current while in on-state. A 3 kV isolated evaluation gate drive board (GA03IDDJT30-FR4) utilizing this topology is commercially available for high and low-side driving, its datasheet provides additional details about this drive topology.

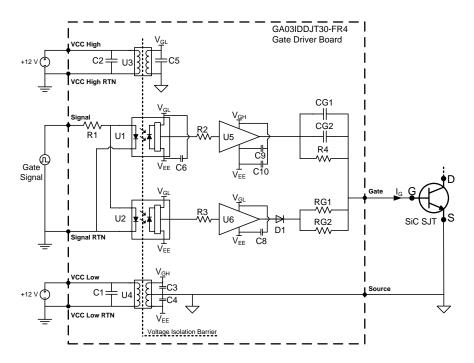


Figure 11: Topology of the GA03IDDJT30-FR4 Two Voltage Source gate driver.

The GA03IDDJT30-FR4 evaluation board comes equipped with two on board gate drive resistors (RG1, RG2) pre-installed for an effective gate resistance<sup>3</sup> of  $R_G = 3.75 \Omega$ . It may be necessary for the user to reduce RG1 and RG2 under high drain current conditions for safe operation of the GA20JT06- CAL. The steady state current supplied to the gate pin of the GA20JT06- CAL with on-board  $R_G = 3.75 \Omega$ , is shown in Figure 12. The maximum allowable safe value of  $R_G$  for the user's required drain current can be read from Figure 13.

#### For the GA20JT06-CAL, R<sub>G</sub> must be reduced for I<sub>D</sub> ≥ ~13 A for safe operation with the GA03IDDJT30-FR4.

For operation at  $I_D \ge \sim 13$  A,  $R_G$  may be calculated from the following equation, which contains the DC current gain  $h_{FE}$  (Figure 6) and the gate-source saturation voltage  $V_{GS,sat}$  (Figure 5).

$$R_{G,max} = \frac{\left(4.7V - V_{GS,sat}\right) * h_{FE}(T,I_D)}{I_D * 1.5} - 0.6\Omega$$

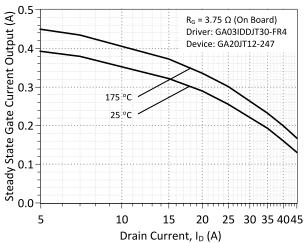


Figure 12: Typical steady state gate current supplied by the GA03IDDJT30-FR4 board for the GA20JT06-CAL with the on board resistance of 3.75  $\Omega\,$ 

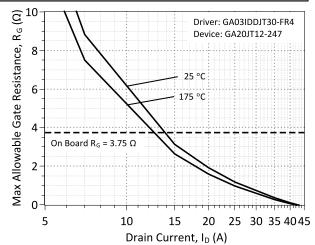


Figure 13: Maximum gate resistance for safe operation of the GA20JT06-CAL at different drain currents using the GA03IDDJT30-FR4 board.

#### B:2: High Speed, Low Loss Drive with Boost Inductor

A High Speed, Low-Loss Driver with Boost Inductor is also capable of driving the GA06JT12- CAL at high-speed. It utilizes a gate drive inductor instead of a capacitor to provide the high-current gate current pulses  $I_{G,on}$  and  $I_{G,off}$ . During operation, inductor L is charged to a specified  $I_{G,on}$  current value then made to discharge  $I_L$  into the SJT gate pin using logic control of  $S_1$ ,  $S_2$ ,  $S_3$ , and  $S_4$ , as shown in Figure 14. After turn on, while the device remains on the necessary steady state gate current  $I_{G,steady}$  is supplied from source  $V_{CC}$  through  $R_G$ . Please refer to the article "A current-source concept for fast and efficient driving of silicon carbide transistors" by Dr. Jacek Rąbkowski for additional information on this driving topology.<sup>4</sup>

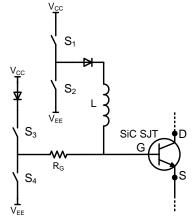


Figure 14: Simplified Inductive Pulsed Drive Topology

 $<sup>^{3}</sup>$  – R<sub>G</sub> = (1/RG1 +1/RG2) $^{-1}$ . Driver is pre-installed with RG1 = RG2 = 7.5  $\Omega$ 

<sup>4 -</sup> Archives of Electrical Engineering. Volume 62, Issue 2, Pages 333–343, ISSN (Print) 0004-0746, DOI: 10.2478/aee-2013-0026, June 2013

### C: Proportional Gate Current Driving

For applications in which the GA20JT06- CAL will operate over a wide range of drain current conditions, it may be beneficial to drive the device using a proportional gate drive topology to optimize gate drive power consumption. A proportional gate driver relies on instantaneous drain current  $I_D$  feedback to vary the steady state gate current  $I_{G,steady}$  supplied to the GA20JT06- CAL

#### C:1: Voltage Controlled Proportional Driver

The voltage controlled proportional driver relies on a gate drive IC to detect the GA20JT06- CAL drain-source voltage  $V_{DS}$  during on-state to sense  $I_D$ . The gate drive IC will then increase or decrease  $I_{G,steady}$  in response to  $I_D$ . This allows  $I_{G,steady}$ , and thus the gate drive power consumption, to be reduced while  $I_D$  is relatively low or for  $I_{G,steady}$  to increase when is  $I_D$  higher. A high voltage diode connected between the drain and sense protects the IC from high-voltage when the driver and GA20JT06- CAL are in off-state. A simplified version of this topology is shown in Figure 15, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/

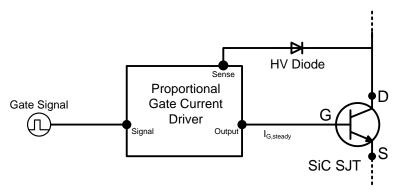


Figure 15: Simplified Voltage Controlled Proportional Driver

#### C:2: Current Controlled Proportional Driver

The current controlled proportional driver relies on a low-loss transformer in the drain or source path to provide feedback  $I_D$  of the GA20JT06-CAL during on-state to supply  $I_{G,steady}$  into the device gate.  $I_{G,steady}$  will then increase or decrease in response to  $I_D$  at a fixed forced current gain which is set be the turns ratio of the transformer,  $h_{force} = I_D / I_G = N_2 / N_1$ . GA20JT06- CAL is initially tuned-on using a gate current pulse supplied into an RC drive circuit to allow  $I_D$  current to begin flowing. This topology allows  $I_{G,steady}$ , and thus the gate drive power consumption, to be reduced while  $I_D$  is relatively low or for  $I_{G,steady}$  to increase when is  $I_D$  higher. A simplified version of this topology is shown in Figure 16, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/.

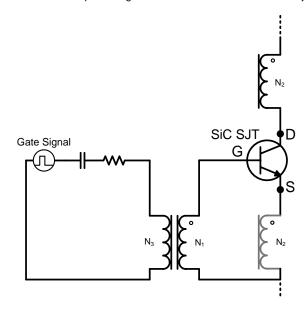


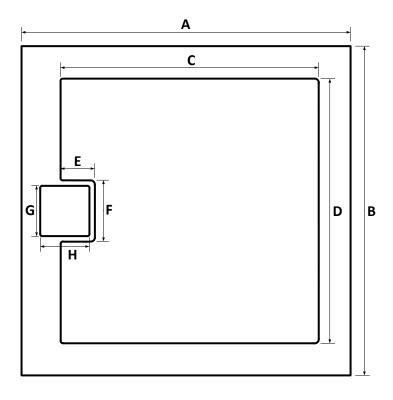
Figure 16: Simplified Current Controlled Proportional Driver



## **Mechanical Parameters**

Die Dimensions	2.85 x 2.85	mm <sup>2</sup>	112 x 112	mil <sup>2</sup>		
Die Area total / active	8.12/6.60	mm²	12544/10237	mil <sup>2</sup>		
Die Thickness	360	μm	mil			
Wafer Size	100	mm	3937	mil		
Flat Position	0	deg	0	deg		
Die Frontside Passivation		Polyimide				
Gate/Source Pad Metallization		4000 nm Al				
Bottom Drain Pad Metallization		400 nm Ni + 200 nm Au				
Die Attach	Elec	Electrically conductive glue or solder				
Wire Bond		Al ≤ 10 mil (Source) Al ≤ 3 mil (Gate)				
Reject ink dot size		Φ ≥ 0.3 mm				
Recommended storage environment	Store in	Store in original container, in dry nitrogen,				
	< 6 month	< 6 months at an ambient temperature of 23 °C				

# **Chip Dimensions:**



		mm	mil
DIE	Α	2.85	112
	В	2.85	112
SOURCE WIREBONDABLE	С	2.23	88
	D	2.29	90
	Е	0.30	12
	F	0.53	21
GATE WIREBONDABLE	G	0.44	17
	Н	0.43	17



# **Die Datasheet**

# GA20JT06-CAL

Revision History						
Date	Revision	Comments	Supersedes			
2015/02/09	9	Updated Electrical Characteristics				
2014/08/26	3	Updated Electrical Characteristics				
2014/04/29	2	Updated Electrical Characteristics				
2014/02/27	1	Updated Electrical Characteristics				
2013/12/04	0	Initial release				

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### **SPICE Model Parameters**

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/hit\_sic/baredie/sjt/GA20JT06-CAL\_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GA20JT06-CAL.

```
MODEL OF GeneSiC Semiconductor Inc.
     $Revision:
                  1.1
     $Date: 27-FEB-2014
     GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
     Dulles, VA 20166
     COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
 These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
 OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
 TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
 Models accurate up to 2 times rated drain current.
.model GA20JT06 NPN
+ IS
           5.00E-47
           1.26E-28
+ ISE
+ EG
           3.23
+ BF
           114
+ BR
           0.55
           700
+ IKF
+ NF
           1
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+ NE
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+ RE
           0.01
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+ VJE
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+ MJE
           0.4821112143335
+ XTI
           3
+ XTB
           -1.2
           6.20E-03
+ TRC1
           600
+ VCEO
+ ICRATING 20
           GeneSiC_Semiconductor
+ MFG
 End of GA20JT06-CAL SPICE Model
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